# **SWITCHMODE** <sup>™</sup> NPN Silicon Power Transistors

The BUX85G is designed for high voltage, high speed power switching applications like converters, inverters, switching regulators, motor control systems.

#### **Features**

- V<sub>CEO(sus)</sub> 450 V
- V<sub>CES(sus)</sub> 1000 V
- Fall time =  $0.3 \mu s$  (typ) at  $I_C = 1.0 A$
- $V_{CE(sat)} = 1.0 \text{ V (max)}$  at  $I_C = 1.0 \text{ A}$ ,  $I_B = 0.2 \text{ A}$
- These Devices are Pb-Free and are RoHS Compliant\*

#### **MAXIMUM RATINGS**

| Rating   | Symbol                            | Value       | Unit      |
|--|-----------------------------------|-------------|-----------|
| Collector-Emitter Voltage  | V <sub>CEO(sus)</sub>             | 450         | Vdc       |
| Collector-Emitter Voltage  | V <sub>CES</sub>                  | 1000        | Vdc       |
| Emitter-Base Voltage   | V <sub>EBO</sub>                  | 5           | Vdc       |
| Collector Current – Continuous – Peak (Note 1)                     | I <sub>C</sub>                    | 2<br>3.0    | Adc       |
| Base Current – Continuous – Peak (Note 1)                          | I <sub>B</sub><br>I <sub>BM</sub> | 0.75<br>1.0 | Adc       |
| Reverse Base Current - Peak  | I <sub>BM</sub>                   | 1           | Adc       |
| Total Device Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C | P <sub>D</sub>                    | 50<br>400   | W<br>W/°C |
| Operating and Storage Junction<br>Temperature Range                | T <sub>J</sub> , T <sub>stg</sub> | -65 to +150 | °C        |

## THERMAL CHARACTERISTICS

| Characteristics  | Symbol          | Max  | Unit |
|--|-----------------|------|------|
| Thermal Resistance, Junction-to-Case   | $R_{\theta JC}$ | 2.5  | °C/W |
| Thermal Resistance, Junction-to-Ambient                                      | $R_{\theta JA}$ | 62.5 | °C/W |
| Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds | TL              | 275  | °C   |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

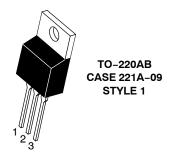
1. Pulse Test: Pulse Width = 5 ms, Duty Cycle ≤ 10%.



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2.0 AMPERES
POWER TRANSISTOR
NPN SILICON
450 VOLTS, 50 WATTS



## **MARKING DIAGRAM**



BUX85 = Device Code A = Assembly Location

Y = Year

WW = Work Week

G = Pb-Free Package

#### **ORDERING INFORMATION**

| Device | Package             | Shipping        |
|--------|---------------------|-----------------|
| BUX85G | TO-220<br>(Pb-Free) | 50 Units / Rail |

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25 °C unless otherwise noted)

|   | Symbol   | Min                   | Тур           | Max           | Unit       |      |
|---|--|-----------------------|---------------|---------------|------------|------|
| OFF CHARACTERIST  | TICS (Note 2)                                    |                       |               | , ,,          |            |      |
| Collector–Emitter Sustaining Voltage (I <sub>C</sub> = 100 mAdc, (L = 25 mH) See Figure 1   |  | V <sub>CEO(sus)</sub> | 450           | -             | _          | Vdc  |
| Collector Cutoff Current<br>(V <sub>CES</sub> = Rated Value)<br>(V <sub>CES</sub> = Rated Value, T <sub>C</sub> = 125°C)              |  | I <sub>CES</sub>      | -<br>-        | -<br>-        | 0.2<br>1.5 | mAdc |
| Emitter Cutoff Current $(V_{EB} = 5 \text{ Vdc}, I_C = 0)$  |  | I <sub>EBO</sub>      | -             | _             | 1          | mAdc |
| ON CHARACTERISTI  | CS (Note 2)                                      |                       |               |               |            | •    |
| DC Current Gain (I <sub>C</sub> = 0.1 Adc, V <sub>CE</sub> = 5 V)   |  | h <sub>FE</sub>       | 30            | 50            | -          | -    |
| Collector–Emitter Saturation Voltage $(I_C = 0.3 \text{ Adc}, I_B = 30 \text{ mAdc})$ $(I_C = 1 \text{ Adc}, I_B = 200 \text{ mAdc})$ |  | V <sub>CE(sat)</sub>  | <u>-</u><br>- | <u>-</u><br>- | 0.8<br>1   | Vdc  |
| Base–Emitter Saturation Voltage ( $I_C = 1 \text{ Adc}$ , $I_B = 0.2 \text{ Adc}$ )   |  | V <sub>BE(sat)</sub>  | _             | -             | 1.1        | Vdc  |
| DYNAMIC CHARACT   | ERISTICS   |                       |               |               |            |      |
| Current–Gain – Bandwidth Product ( $I_C = 500 \text{ mAdc}$ , $V_{CE} = 1 \text{ 0 Vdc}$ , $f = 1 \text{ MHz}$ )                      |  | f <sub>T</sub>        | 4             | _             | -          | MHz  |
| SWITCHING CHARAC  | TERISTICS  |                       |               |               |            |      |
| Turn-on Time  | V <sub>CC</sub> = 250 Vdc, I <sub>C</sub> = 1 A  | t <sub>on</sub>       | -             | 0.3           | 0.5        | μs   |
| Storage Time  | I <sub>B1</sub> = 0.2 A, I <sub>B2</sub> = 0.4 A | t <sub>s</sub>        | -             | 2             | 3.5        | μs   |
| Fall Time   | See Figure 2                                     | t <sub>f</sub>        | -             | 0.3           | -          | μs   |
| Fall Time   | I Time Same above cond. at T <sub>C</sub> = 95°C |                       | -             | _             | 1.4        | μs   |

<sup>2.</sup> Pulse Test: PW = 300 μs, Duty Cycle ≦2%.

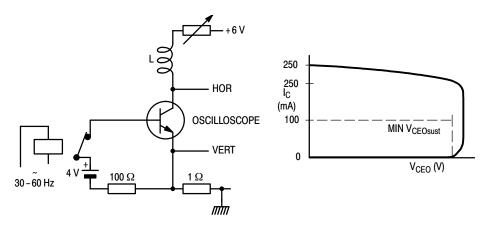


Figure 1. Test Circuit for V<sub>CEOsust</sub>

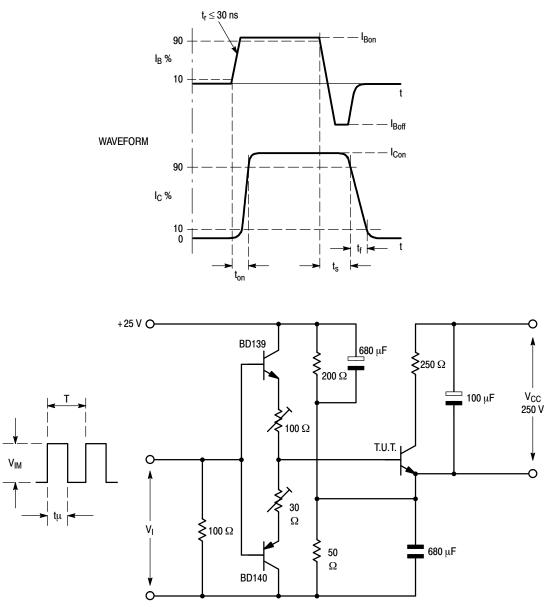
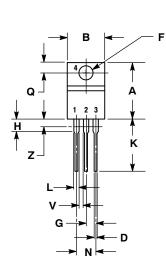
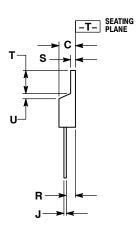


Figure 2. Switching Times/Test Circuit

## PACKAGE DIMENSIONS

## TO-220AB CASE 221A-09 ISSUE AF





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
   Y14 EM 1092
- Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

|     | INCHES |       | MILLIMETERS |       |
|-----|--------|-------|-------------|-------|
| DIM | MIN    | MAX   | MIN         | MAX   |
| Α   | 0.570  | 0.620 | 14.48       | 15.75 |
| В   | 0.380  | 0.405 | 9.66        | 10.28 |
| С   | 0.160  | 0.190 | 4.07        | 4.82  |
| D   | 0.025  | 0.035 | 0.64        | 0.88  |
| F   | 0.142  | 0.161 | 3.61        | 4.09  |
| G   | 0.095  | 0.105 | 2.42        | 2.66  |
| Н   | 0.110  | 0.155 | 2.80        | 3.93  |
| J   | 0.014  | 0.025 | 0.36        | 0.64  |
| K   | 0.500  | 0.562 | 12.70       | 14.27 |
| L   | 0.045  | 0.060 | 1.15        | 1.52  |
| N   | 0.190  | 0.210 | 4.83        | 5.33  |
| Q   | 0.100  | 0.120 | 2.54        | 3.04  |
| R   | 0.080  | 0.110 | 2.04        | 2.79  |
| S   | 0.045  | 0.055 | 1.15        | 1.39  |
| T   | 0.235  | 0.255 | 5.97        | 6.47  |
| U   | 0.000  | 0.050 | 0.00        | 1.27  |
| ٧   | 0.045  |       | 1.15        |       |
| Z   |        | 0.080 |             | 2.04  |

STYLE 1:

PIN 1. BASE

- 2. COLLECTOR
- 3. EMITTER
- 4. COLLECTOR

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